

DS90LV049H 高温 3V LVDS 双路线路驱动器和接收器组合

1 特性

- +125°C 的高温工作范围
- 转换速率高达 400Mbps
- 直通引脚排列可简化 PCB 布局
- 50ps 典型驱动器通道到通道偏斜
- 50ps 典型接收器通道到通道偏斜
- 3.3V 单电源设计
- TRI-STATE 输出控制
- 《接收器输入的失效防护偏置》
- 低功耗（3.3V 静态条件下为 70mW）
- 在断电模式下，LVDS 输出端具有高阻抗
- 符合 TIA/EIA-644-A LVDS 标准
- 采用薄型 16 引脚 TSSOP 封装

2 应用

- 板对板通信
- 测试和测量
- 电机驱动器
- LED 视频墙
- 无线基础设施
- 电信基础设施
- 多功能打印机
- NIC 卡
- 机架式服务器
- 超声波扫描仪

3 说明

DS90LV049H 器件是一款双路 CMOS 差分线路驱动器-接收器对，专为需要超低功耗、出色的抗噪能力以及高数据吞吐量的应用而设计。该器件旨在利用低电压差分信号 (LVDS) 技术支持超过 400Mbps 的数据速率。DS90LV049H TSSOP 封装采用了直通式布线，可简化 PCB 布局。

DS90LV049H 驱动器接受 LVTTTL/LVCMOS 信号，并且可将其转换为 LVDS 信号。接收器接受 LVTTTL 信号，并且可将其转换为 3V CMOS 信号。LVDS 输入缓冲器具有内部失效防护偏置，可为浮点接收器输入将输出置于已知的 H（高）状态。另外，DS90LV049H 支持 TRI-STATE 功能，以达到当器件未使用时处于低空闲功耗状态。

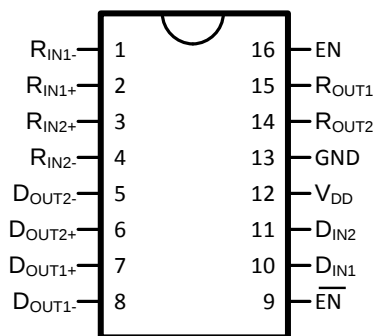
EN 和 $\overline{\text{EN}}$ 输入将接受 AND 运算并控制 TRI-STATE 输出。这些使能端由四个门共用。

器件信息⁽¹⁾

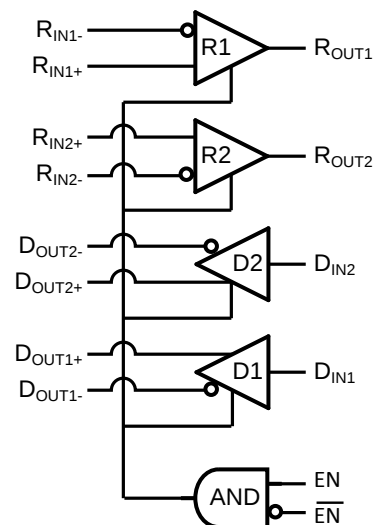
器件型号	封装	封装尺寸（标称值）
DS90LV049H	TSSOP (16)	5.00mm × 4.40mm

(1) 如需了解所有可用封装，请参阅数据表末尾的可订购产品附录。

双列直插式



功能图



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4 修订历史记录

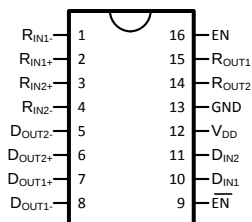
注：之前版本的页码可能与当前版本有所不同。

Changes from Revision A (April 2013) to Revision B	Page
• 添加了器件信息表、器件比较表、ESD 额定值表、特性说明部分、器件功能模式、应用和实施部分、电源相关建议部分、布局部分、器件和文档支持部分以及机械、封装和可订购信息部分。	1
• 添加了导航链接，移除了数据表页顶端的 NRND 横幅	1
• Moved the thermal resistance (θ_{JA}) parameter in the <i>Absolute Maximum Ratings</i> table to the <i>Thermal Information</i> table	4

Changes from Original (April 2013) to Revision A	Page
• Changed layout of National Data Sheet to TI format	17

5 Pin Configuration and Functions

**PW Package
16-Pin TSSOP
Top View**



Pin Functions

PIN		I/O	DESCRIPTION
NAME	NO.		
D _{IN}	10, 11	I	Driver input pins, LVCMOS levels. There is a pulldown current source present.
D _{OUT+}	6, 7	O	Noninverting driver output pins, LVDS levels.
D _{OUT-}	5, 8	O	Inverting driver output pins, LVDS levels.
R _{IN+}	2, 3	I	Noninverting receiver input pins, LVDS levels. There is a pullup current source present.
R _{IN-}	1, 4	I	Inverting receiver input pins, LVDS levels. There is a pulldown current source present.
R _{OUT}	14, 15	O	Receiver output pins, LVCMOS levels.
EN, $\overline{\text{EN}}$	9, 16	I	Enable and Disable pins. There are pulldown current sources present at both pins.
V _{DD}	12	I	Power supply pin.
GND	13	I	Ground pin.

6 Specifications

6.1 Absolute Maximum Ratings⁽¹⁾⁽²⁾

		MIN	MAX	UNIT
Supply Voltage (V _{DD})		-0.3	4	V
LVCMOS Input Voltage (D _{IN})		-0.3	(V _{DD} + 0.3)	V
LVDS Input Voltage (R _{IN+} , R _{IN-})		-0.3		V
Enable Input Voltage (EN, $\overline{EN}$)		-0.3	(V _{DD} + 0.3)	V
LVCMOS Output Voltage (R _{OUT})		-0.3	(V _{DD} + 0.3)	V
LVDS Output Voltage (D _{OUT+} , D _{OUT-})		-0.3	3.9	V
LVCMOS Output Short Circuit Current (R _{OUT})			100	mA
LVDS Output Short Circuit Current (D _{OUT+} , D _{OUT-})			24	mA
LVDS Output Short Circuit Current Duration (D _{OUT+} , D _{OUT-})		Continuous		
Lead Temperature Range	Soldering (4 sec.)	260		°C
Maximum Junction Temperature		150		°C
Maximum Package Power Dissipation at +25°C	PW0016A Package	866		mW
	Derate PW0016A Package (above +25°C)	6.9		mW/°C
Storage Temperature, T _{stg}		-65	150	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) If Military/Aerospace specified devices are required, please contact the Texas Instruments Sales Office/Distributors for availability and specifications.

6.2 ESD Ratings

	VALUE	UNIT
$V_{(ESD)}$ Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾ (1.5 k Ω , 100 pF)	7000
	(MM, 0 Ω , 200 pF)	250

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process. Pins listed as ± 7000 V may actually have higher performance.

6.3 Recommended Operating Conditions

	MIN	TYP	MAX	UNIT
Supply Voltage (V_{DD})	+3.0	+3.3	+3.6	V
Ambient Temperature (T_A)	-40	25	+125	°C
Junction Temperature (T_J)			+130	°C

6.4 Thermal Information

THERMAL METRIC ⁽¹⁾		DS90LV049H	UNIT
		PW (TSSOP)	
		16 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	109.9	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	40.8	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	57	°C/W
ψ_{JT}	Junction-to-top characterization parameter	4.4	°C/W
ψ_{JB}	Junction-to-board characterization parameter	56.3	°C/W

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

6.5 Electrical Characteristics

Over supply voltage and operating temperature ranges, unless otherwise specified. ⁽¹⁾⁽²⁾⁽³⁾

PARAMETER		TEST CONDITIONS		PIN	MIN	TYP	MAX	UNIT	
LVCMOS Input DC Specifications (Driver Inputs, ENABLE Pins)									
V _{IH}	Input High Voltage			D _{IN} EN EN	2		V _{DD}	V	
V _{IL}	Input Low Voltage				GND		0.8	V	
I _{IH}	Input High Current	V _{IN} = V _{DD}			-10	1	+10	μA	
I _{IL}	Input Low Current	V _{IN} = GND			-10	-0.1	+10	μA	
V _{CL}	Input Clamp Voltage	I _{CL} = -18 mA			-1.5	-0.6		V	
LVDS Output DC Specifications (Driver Outputs)									
V _{OD}	Differential Output Voltage	R _L = 100 Ω (Figure 2)	D _{OUT} - D _{OUT} +	250	350	450	mV		
ΔV _{OD}	Change in Magnitude of V _{OD} for Complementary Output States				1	35	mV		
V _{OS}	Offset Voltage			1.125	1.23	1.375	V		
ΔV _{OS}	Change in Magnitude of V _{OS} for Complementary Output States				1	25	mV		
I _{OS}	Output Short-Circuit Current ⁽⁴⁾	ENABLED, D _{IN} = V _{DD} , D _{OUT} + = 0 V or D _{IN} = GND, D _{OUT} - = 0 V			-5.8	-9	mA		
I _{OSD}	Differential Output Short-Circuit Current ⁽⁴⁾	ENABLED, V _{OD} = 0 V			-5.8	-9	mA		
I _{OFF}	Power-off Leakage	V _{OUT} = 0 V or 3.6 V V _{DD} = 0 V or Open			-20	±1	+20	μA	
I _{OZ}	Output TRI-STATE Current	EN = 0 V and $\overline{\text{EN}}$ = V _{DD} V _{OUT} = 0 V or V _{DD}		-10	±1	+10	μA		
LVDS Input DC Specifications (Receiver Inputs)									
V _{TH}	Differential Input High Threshold	V _{CM} = 1.2 V, 0.05 V, 2.35 V	R _{IN} + R _{IN} -		-15	35	mV		
V _{TL}	Differential Input Low Threshold				-100	-15	mV		
V _{CMR}	Common-Mode Voltage Range				0.05		3	V	
I _{IN}	Input Current			V _{DD} =3.6 V V _{IN} =0 V or 2.8 V		-12	±4	+12	μA
				V _{DD} =0 V V _{IN} =0 V or 2.8 V or 3.6 V		-10	±1	+10	μA
LVCMOS Output DC Specifications (Receiver Outputs)									
V _{OH}	Output High Voltage	I _{OH} = -0.4 mA, V _{ID} = 200 mV	R _{OUT}	2.7	3.3		V		
V _{OL}	Output Low Voltage	I _{OL} = 2 mA, V _{ID} = 200 mV			0.05	0.25	V		
I _{OZ}	Output TRI-STATE Current	Disabled, V _{OUT} =0 V or V _{DD}			-10	±1	+10	μA	
General DC Specifications									
I _{DD}	Power Supply Current ⁽⁵⁾	EN = 3.3 V	V _{DD}		21	35	mA		
I _{DDZ}	TRI-State Supply Current	EN = 0 V			15	25	mA		

- (1) Current into device pins is defined as positive. Current out of device pins is defined as negative. All voltages are referenced to ground except: V_{TH}, V_{TL}, V_{OD} and ΔV_{OD}.
- (2) All typical values are given for: V_{DD} = +3.3 V, T_A = +25°C.
- (3) The DS90LV049H's drivers are current mode devices and only function within datasheet specifications when a resistive load is applied to their outputs. The typical range of the resistor values is 90 Ω to 110 Ω.
- (4) Output short circuit current (I_{OS}) is specified as magnitude only, minus sign indicates direction only.
- (5) Both driver and receiver inputs are static. All LVDS outputs have 100 Ω load. All LVCMOS outputs are floating. None of the outputs have any lumped capacitive load.

6.6 Switching Characteristics

 $V_{DD} = +3.3V \pm 10\%$, $T_A = -40^\circ C$ to $+125^\circ C^{(1)(2)}$

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
LVDS Outputs (Driver Outputs)						
t_{PHLD}	Differential Propagation Delay High to Low	$R_L = 100\ \Omega$ (Figure 3 and Figure 4)		0.7	2	ns
t_{PLHD}	Differential Propagation Delay Low to High			0.7	2	ns
t_{SKD1}	Differential Pulse Skew $ t_{PHLD} - t_{PLHD} ^{(3)(4)}$		0	0.05	0.4	ns
t_{SKD2}	Differential Channel-to-Channel Skew ⁽³⁾⁽⁵⁾		0	0.05	0.5	ns
t_{SKD3}	Differential Part-to-Part Skew ⁽³⁾⁽⁶⁾		0		1	ns
t_{TLH}	Rise Time ⁽³⁾		0.2	0.4	1	ns
t_{THL}	Fall Time ⁽³⁾		0.2	0.4	1	ns
t_{PHZ}	Disable Time High to Z	$R_L = 100\ \Omega$ (Figure 5 and Figure 6)		1.5	3	ns
t_{PLZ}	Disable Time Low to Z			1.5	3	ns
t_{PZH}	Enable Time Z to High		1	3	6	ns
t_{PZL}	Enable Time Z to Low		1	3	6	ns
f_{MAX}	Maximum Operating Frequency ⁽⁷⁾		200	250		MHz
LVCMOS Outputs (Receiver Outputs)						
t_{PHL}	Propagation Delay High to Low	(Figure 7 and Figure 8)	0.5	2	3.5	ns
t_{PLH}	Propagation Delay Low to High		0.5	2	3.5	ns
t_{SK1}	Pulse Skew $ t_{PHL} - t_{PLH} ^{(8)}$		0	0.05	0.4	ns
t_{SK2}	Channel-to-Channel Skew ⁽⁹⁾		0	0.05	0.5	ns
t_{SK3}	Part-to-Part Skew ⁽¹⁰⁾		0		1	ns
t_{TLH}	Rise Time ⁽³⁾		0.3	0.9	1.4	ns
t_{THL}	Fall Time ⁽³⁾		0.3	0.75	1.4	ns
t_{PHZ}	Disable Time High to Z	(Figure 9 and Figure 10)	3	5.6	8	ns
t_{PLZ}	Disable Time Low to Z		3	5.4	8	ns
t_{PZH}	Enable Time Z to High		2.5	4.6	7	ns
t_{PZL}	Enable Time Z to Low		2.5	4.6	7	ns
f_{MAX}	Maximum Operating Frequency ⁽¹¹⁾		200	250		MHz

(1) All typical values are given for: $V_{DD} = +3.3\ V$, $T_A = +25^\circ C$.

(2) Generator waveform for all tests unless otherwise specified: $f = 1\ MHz$, $Z_O = 50\ \Omega$, $t_r \leq 1\ ns$, and $t_f \leq 1\ ns$.

(3) These parameters are specified by design. The limits are based on statistical analysis of the device performance over PVT (process, voltage, temperature) ranges.

(4) t_{SKD1} or differential pulse skew is defined as $|t_{PHLD} - t_{PLHD}|$. It is the magnitude difference in the differential propagation delays between the positive going edge and the negative going edge of the same driver channel.

(5) t_{SKD2} or differential channel-to-channel skew is defined as the magnitude difference in the differential propagation delays between two driver channels on the same device.

(6) t_{SKD3} or differential part-to-part skew is defined as $|t_{PLHD\ Max} - t_{PLHD\ Min}|$ or $|t_{PHLD\ Max} - t_{PHLD\ Min}|$. It is the difference between the minimum and maximum specified differential propagation delays. This specification applies to devices at the same V_{DD} and within $5^\circ C$ of each other within the operating temperature range.

(7) f_{MAX} generator input conditions: $t_r = t_f < 1\ ns$ (0% to 100%), 50% duty cycle, 0 V to 3 V. Output Criteria: duty cycle = 45%/55%, $V_{OD} > 250\ mV$, all channels switching.

(8) t_{SK1} or pulse skew is defined as $|t_{PHL} - t_{PLH}|$. It is the magnitude difference in the propagation delays between the positive going edge and the negative going edge of the same receiver channel.

(9) t_{SK2} or channel-to-channel skew is defined as the magnitude difference in the propagation delays between two receiver channels on the same device.

(10) t_{SK3} or part-to-part skew is defined as $|t_{PLH\ Max} - t_{PLH\ Min}|$ or $|t_{PHL\ Max} - t_{PHL\ Min}|$. It is the difference between the minimum and maximum specified propagation delays. This specification applies to devices at the same V_{DD} and within $5^\circ C$ of each other within the operating temperature range.

(11) f_{MAX} generator input conditions: $t_r = t_f < 1\ ns$ (0% to 100%), 50% duty cycle, $V_{ID} = 200\ mV$, $V_{CM} = 1.2\ V$. Output Criteria: duty cycle = 45%/55%, $V_{OH} > 2.7\ V$, $V_{OL} < 0.25\ V$, all channels switching.

6.7 Typical Characteristics

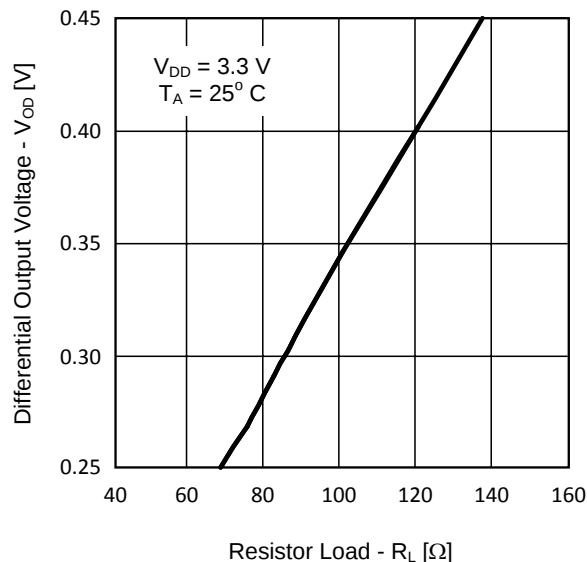


Figure 1. Differential Output Voltage vs Load Resistor

7 Parameter Measurement Information

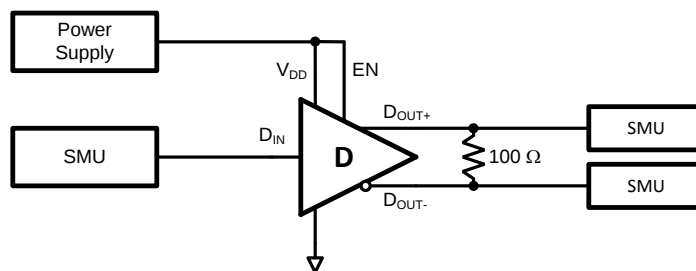


Figure 2. Driver V_{OD} and V_{OS} Test Circuit

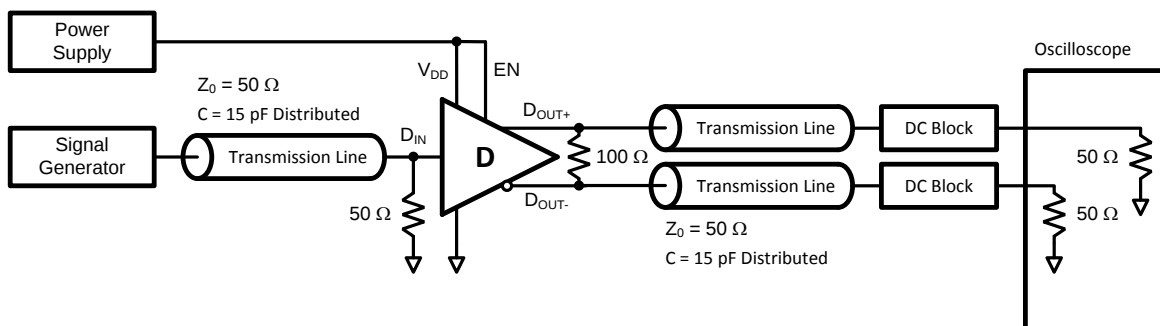
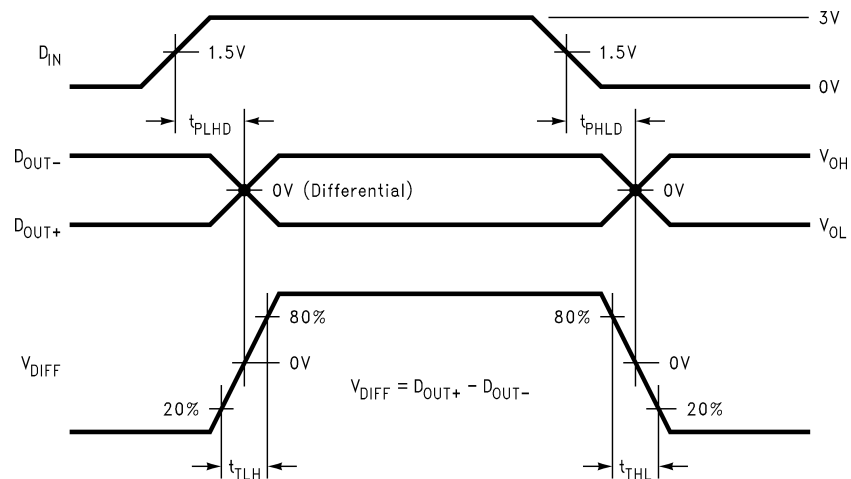
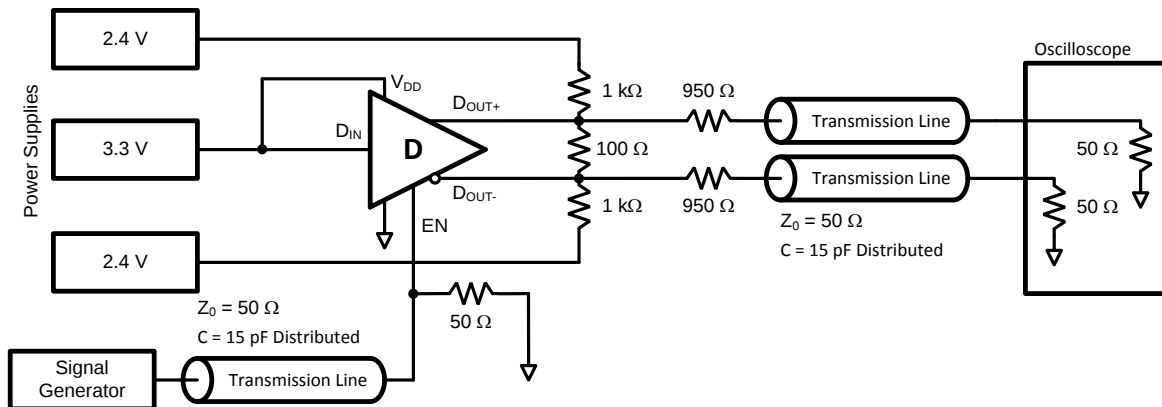
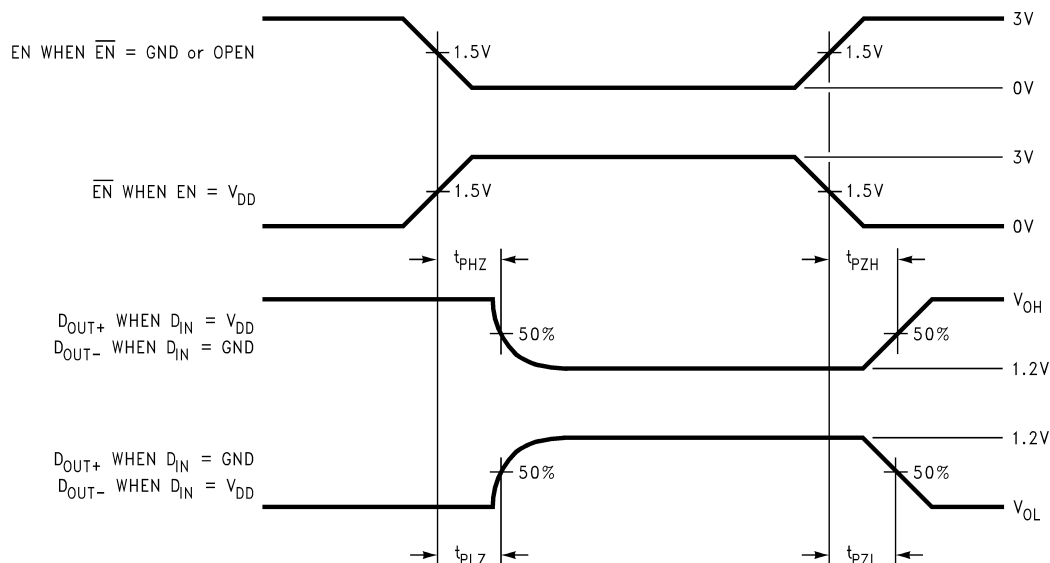


Figure 3. Driver Propagation Delay and Transition Time Test Circuit

Parameter Measurement Information (continued)

Figure 4. Driver Propagation Delay and Transition Time Waveforms

Figure 5. Driver TRI-STATE Delay Test Circuit

Figure 6. Driver TRI-STATE Delay Waveform

Parameter Measurement Information (continued)

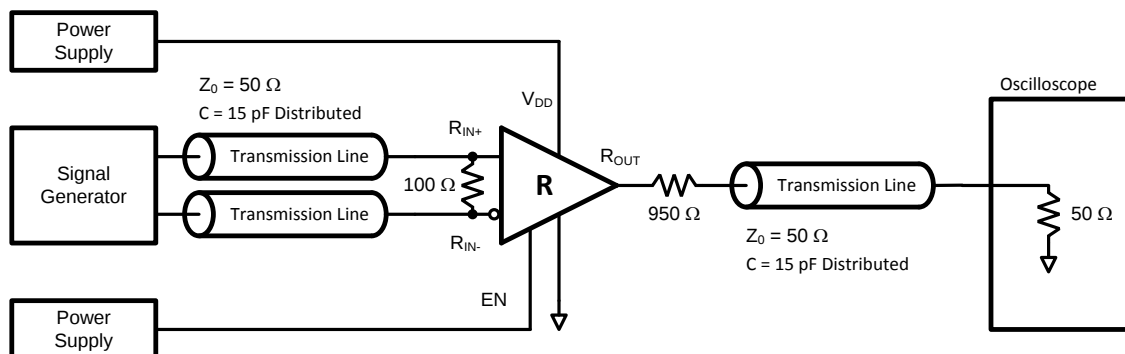


Figure 7. Receiver Propagation Delay and Transition Time Test Circuit

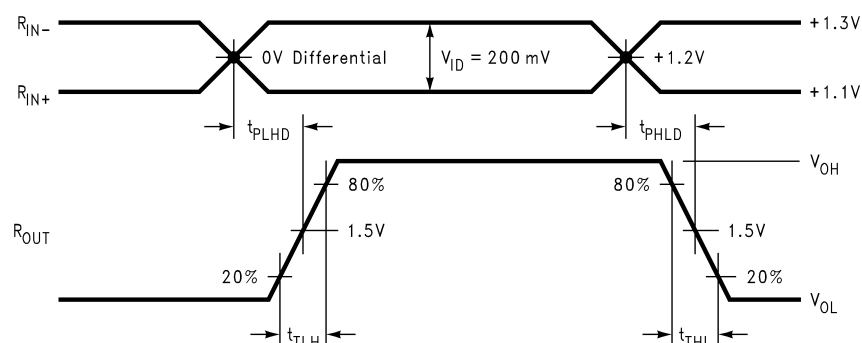


Figure 8. Receiver Propagation Delay and Transition Time Waveforms

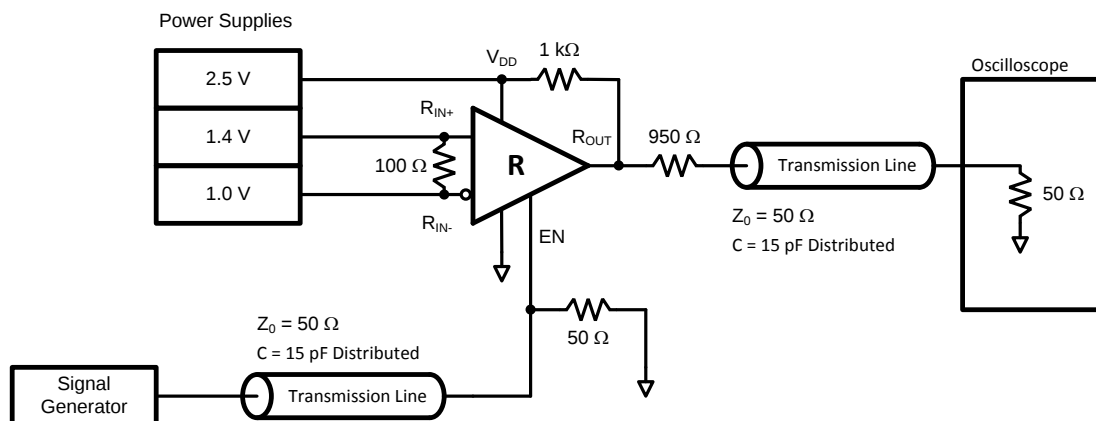
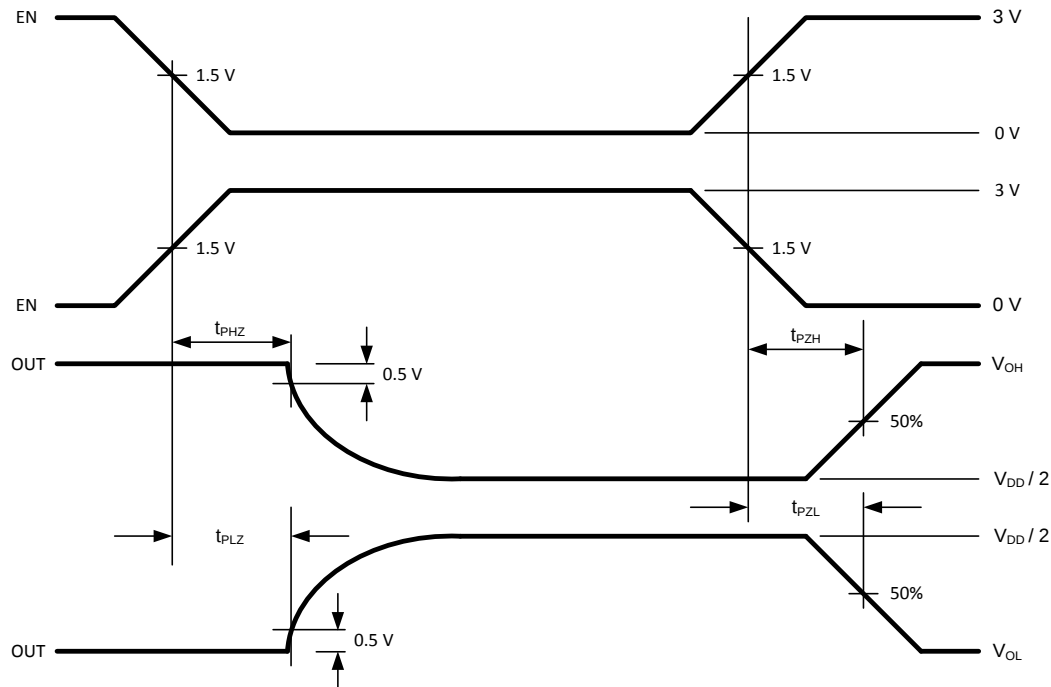


Figure 9. Receiver TRI-STATE Delay Test Circuit

Parameter Measurement Information (continued)

Figure 10. Receiver TRI-STATE Delay Waveforms

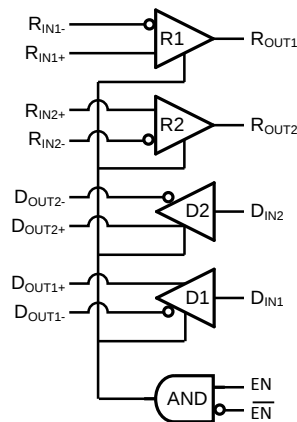
8 Detailed Description

8.1 Overview

The DS90LV049H integrates both low-voltage differential signaling (LVDS) line drivers, with a balanced current source design, and LVDS line receivers into a single package. This device operates from a single power supply that is nominally 3.3 V, but the supply can be as low as 3.0 V and as high as 3.6 V. The input signal to the DS90LV049H LVDS line drivers is an LVCMOS/LVTTL signal. The output of the DS90LV049H LVDS line drivers is a differential signal complying with the LVDS standard (TIA/EIA-644). The input to the DS90LV049H LVDS line receivers is a differential signal complying with the LVDS Standard (TIA/EIA-644) and the output is a 3.3-V LVCMOS/LVTTL signal. The differential output signal of the DS90LV049H LVDS line drivers operates with a signal level of 350 mV, nominally, at a common-mode voltage of 1.2 V. This low differential output voltage results in low electromagnetic interference (EMI). The differential input signal of the DS90LV049H LVDS line receivers operates with a signal level of 350 mV, nominally, at a common-mode voltage of 1.2 V. The differential nature of the LVDS outputs and inputs provides immunity to common-mode coupled signals (noise) that the driven/received signal may experience.

The DS90LV049H is primarily used in point-to-point configurations, as seen in [Figure 11](#). This configuration provides a clean signaling environment for the fast edge rates of the DS90LV049H and other LVDS components. The DS90LV049H is connected through a balanced media which may be a standard twisted-pair cable, a parallel pair cable, or simply PCB traces to a LVDS receiver. Typically, the characteristic differential impedance of the media is in the range of 100 Ω. The DS90LV049H device is intended to drive a 100-Ω transmission line. The 100-Ω termination resistor is selected to match the media and is placed as close to the LVDS receiver input pins as possible.

8.2 Functional Block Diagram



8.3 Feature Description

8.3.1 DS90LV049H LVDS Driver and Receiver Functionality

[Table 1](#) shows how the LVDS driver single-ended input to differential output relationship is defined for DS90LV049H. When the driver input is left open, the differential output is undefined.

Table 1. DS90LV049H LVDS Driver Functionality⁽¹⁾

INPUT	OUTPUT	
D _{INx}	D _{OUTx+}	D _{OUTx-}
H	H	L
L	L	H
Open	?	?

(1) x = 1,2 to indicate pin designation.

Table 2 shows how the LVDS receiver differential input to single-ended output relationship is defined for DS90LV049H. The DS90LV049H receiver is capable of detecting signals as low as 100 mV, over a ± 1 -V common-mode range centered around 1.2 V.

Table 2. DS90LV049H LVDS Receiver Functionality⁽¹⁾

INPUTS	OUTPUT
$V_{ID} = [R_{INx+}] - [R_{INx-}]$	R_{OUTx}
$V_{ID} \geq 0$ V	H
$V_{ID} \leq -0.1$ V	L
Full Fail-Safe OPEN/SHORT or Terminated	H

(1) x = 1,2 to indicate pin designation.

8.3.2 Termination

Use a termination resistor that best matches the differential impedance or the transmission line. The resistor should be between 90 Ω and 130 Ω . Remember that the current mode outputs need the termination resistor to generate the differential voltage. LVDS will not work without resistor termination. Typically, connecting a single resistor across the pair at the receiver end will suffice.

Surface mount 1% to 2% resistors are best. PCB stubs, component lead, and the distance from the termination to the receiver inputs should be minimized. The distance between the termination resistor and the receiver should be < 10 mm (12 mm MAX).

8.3.3 Fail-Safe Feature

The LVDS receiver is a high-gain, high-speed device that amplifies a small differential signal (20 mV) to LVCMOS/LVTTL logic levels. Due to the high gain and tight threshold of the receiver, take care to prevent noise from appearing as a valid signal. The internal fail-safe circuitry of the receiver is designed to source/sink a small amount of current, providing fail-safe protection (a stable known state of HIGH output voltage) for floating, terminated, or shorted receiver inputs.

- Open Input Pins:** It is not required to tie the receiver inputs to ground or any supply voltage. Internal fail-safe circuitry will ensure a HIGH, stable output state for open inputs.
- Terminated Input:** If the driver is disconnected (cable unplugged), or if the driver is in a power-off condition, the receiver output will again be in a HIGH state, even with the end cable 100- Ω termination resistor across the input pins. The unplugged cable can become a floating antenna which can pick up noise. If the cable picks up more than 10 mV of differential noise, the receiver may see the noise as a valid signal and switch. To ensure that any noise is seen as common-mode and not differential, a balanced interconnect should be used. A twisted-pair cable will offer better balance than a flat ribbon cable.
- Shorted Inputs:** If a fault condition occurs that shorts the receiver inputs together, thus resulting in a 0-V differential input voltage, the receiver output will remain in a HIGH state. Shorted input fail-safe is not supported across the common-mode range of the device (GND to 2.4 V). It is only supported with inputs shorted and no external common-mode voltage applied.

External lower value pullup and pulldown resistors (for a stronger bias) may be used to boost fail-safe in the presence of higher noise levels. The pullup and pulldown resistors should be in the 5-k Ω to 15-k Ω range to minimize loading and waveform distortion to the driver. The common-mode bias point should be set to approximately 1.2 V (less than 1.75 V) to be compatible with the internal circuitry. The DS90LV049H is compliant to the original ANSI EIA/TIA-644 specification and is also compliant to the new ANSI EIA/TIA-644-A specification with the exception of the newly added ΔIIN specification. Due to the internal fail-safe circuitry, ΔIIN cannot meet the 6- μ A maximum specified. This exception will not be relevant unless more than 10 receivers are used.

Additional information on the fail-safe biasing of LVDS devices may be found in [AN-1194 Fail-Safe Biasing of LVDS Interfaces](#) (SNLA051).

8.4 Device Functional Modes

Table 3 reflects the functional state of DS90LV049H when EN and $\overline{\text{EN}}$ change state.

Table 3. DS90LV049H Functional Modes

EN	$\overline{\text{EN}}$	LVDS Out	LVC MOS Out
L or Open	L or Open	OFF	OFF
H	L or Open	ON	ON
L or Open	H	OFF	OFF
H	H	OFF	

9 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

LVDS drivers and receivers are intended to be used primarily in a point-to-point configurations as is shown in Figure 11. This configuration provides a clean signaling environment for the fast edge rates of the drivers. The receiver is connected to the driver through a balanced media that may be a standard twisted pair cable, a parallel pair cable, or simply PCB traces. Typically, the characteristic differential impedance of the media is in the range of 100 Ω . A termination resistor of 100 Ω (selected to match the media), and is placed as close to the receiver input pins as possible. The termination resistor converts the driver output current (current mode) into a voltage that is detected by the receiver. Other configurations are possible such as a multi-receiver configuration, but the effects of a mid-stream connector(s), cable stub(s), and other impedance discontinuities as well as ground shifting, noise margin limits, and total termination loading must be taken into account. The TRI-STATE function allows the device outputs to be disabled, thus obtaining an even lower power state when the transmission of data is not required. The DS90LV049H has a flow-through pinout that allows for easy PCB layout. The LVDS signals on one side of the device allow for easy matching of the electrical lengths for the differential pair trace lines between the driver and the receiver, and the signal placement allows the trace lines to be close together to couple noise as common-mode. Noise isolation is achieved with the LVDS signals on one side of the device and the TTL signals on the other side.

9.2 Typical Application

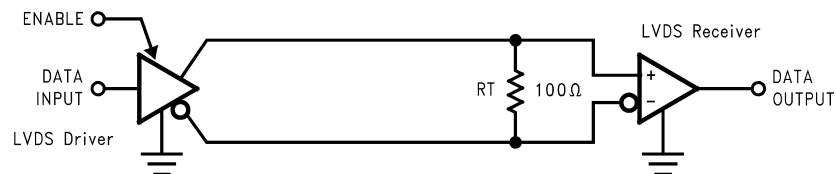


Figure 11. Point-to-Point Application

9.2.1 Design Requirements

Table 4 lists the design parameters for this example.

Table 4. Design Parameters

DESIGN PARAMETER	EXAMPLE VALUE
Supply Voltage (V_{DD})	3 to 3.6 V
Single-ended Input Voltage	0 to V_{DD}
Signaling Rate 1 Ground shift between driver and receiver	0 to 400 Mbps
Interconnect Characteristic Impedance	100 Ω
Number of LVDS Channel	4
Number of Receiver/Transmitter Nodes	2
Ground shift between driver and receiver	± 1 V

9.2.2 Detailed Design Procedure

9.2.2.1 Power Decoupling Recommendations

Bypass capacitors must be used on power pins. Use high frequency ceramic (surface mount is recommended) 0.1-μF and 0.001-μF capacitors in parallel at the power supply pin with the smallest value capacitor closest to the device supply pin.

Bypass capacitors play a key role in power distribution circuitry. Specifically, they create low-impedance paths between power and ground. At low frequencies, a good digital power supply offers very low-impedance paths between its terminals. However, as higher frequency currents propagate through power traces, the source is quite often incapable of maintaining a low-impedance path to ground. Bypass capacitors are used to address this shortcoming. Usually, large bypass capacitors (10 μF to 1000 μF) at the board-level do a good job up into the kHz range. Due to their size and length of their leads, they tend to have large inductance values at the switching frequencies of modern digital circuitry. To solve this problem, one must resort to the use of smaller capacitors (nF to μF range) installed locally next to the integrated circuit.

Multilayer ceramic chip or surface-mount capacitors (size 0603 or 0805) minimize lead inductances of bypass capacitors in high-speed environments, because their lead inductance is about 1 nH. For comparison purposes, a typical capacitor with leads has a lead inductance around 5 nH.

The value of the bypass capacitors used locally with LVDS chips can be determined by [Equation 1](#) and [Equation 2](#) according to Johnson⁽¹⁾ equations 8.18 to 8.21. A conservative rise time of 200 ps and a worst-case change in supply current of 1 A covers the whole range of LVDS devices offered by Texas Instruments. In this example, the maximum power supply noise tolerated is 200 mV. However, this figure varies depending on the noise budget available in the design. ⁽¹⁾

$$C_{\text{chip}} = \left(\frac{\Delta I_{\text{Maximum Step Change Supply Current}}}{\Delta V_{\text{Maximum Power Supply Noise}}} \right) \times T_{\text{Rise Time}} \quad (1)$$

$$C_{\text{LVDS}} = \left(\frac{1\text{A}}{0.2\text{V}} \right) \times 200 \text{ ps} = 0.001 \mu\text{F} \quad (2)$$

[Figure 12](#) lowers lead inductance and covers intermediate frequencies between the board-level capacitor (>10 μF) and the value of capacitance found above (0.001 μF). TI recommends that the user place the smallest value of capacitance as close to the chip as possible.

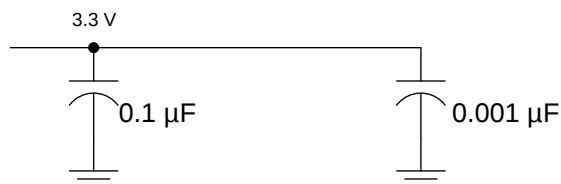


Figure 12. Recommended LVDS Bypass Capacitor Layout

9.2.2.2 PCB Transmission Lines

As per the [LVDS Owner's Manual Design Guide, 4th Edition](#) (SNLA187), [Figure 13](#) depicts several transmission line structures commonly used in printed-circuit boards (PCBs). Each structure consists of a signal line and return path with a uniform cross section along its length. A microstrip is a signal trace on the top (or bottom) layer, separated by a dielectric layer from its return path in a ground or power plane. A stripline is a signal trace in the inner layer, with a dielectric layer in between a ground plane above and below the signal trace. The dimensions of the structure along with the dielectric material properties determine the characteristic impedance of the transmission line (also called controlled-impedance transmission line).

When two signal lines are placed close by, they form a pair of coupled transmission lines. [Figure 13](#) shows examples of edge-coupled microstrip lines, and edge-coupled or broad-side-coupled striplines. When excited by differential signals, the coupled transmission line is referred to as a differential pair. The characteristic impedance of each line is called odd-mode impedance. The sum of the odd-mode impedances of each line is the differential impedance of the differential pair. In addition to the trace dimensions and dielectric material properties, the

(1) Howard Johnson & Martin Graham.1993. High Speed Digital Design – A Handbook of Black Magic. Prentice Hall PRT. ISBN number 013395724.

spacing between the two traces determines the mutual coupling and impacts the differential impedance. When the two lines are immediately adjacent (like if S is less than $2W$, for example), the differential pair is called a tightly-coupled differential pair. To maintain constant differential impedance along the length, it is important to keep the trace width and spacing uniform along the length, as well as maintain good symmetry between the two lines.

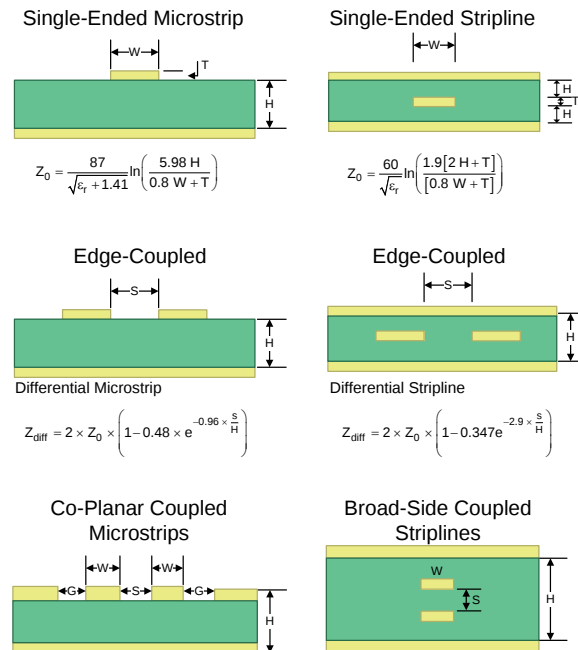


Figure 13. Controlled-Impedance Transmission Lines

9.2.2.3 Input Fail-Safe Biasing

External pullup and pulldown resistors may be used to provide enough of an offset to enable an input fail-safe under open-circuit conditions. This configuration ties the positive LVDS input pin to VDD through a pullup resistor, and the negative LVDS input pin is tied to GND by a pulldown resistor. The pullup and pulldown resistors should be in the 5 kΩ to 15 kΩ range to minimize loading and waveform distortion to the driver. The common-mode bias point should ideally be set to approximately 1.2 V (less than 1.75 V) to be compatible with the internal circuitry. Refer to application note [AN-1194 Fail-Safe Biasing of LVDS Interfaces](#) (SNLA051) for more information.

9.2.2.4 Probing LVDS Transmission Lines on PCB

Always use high impedance ($> 100 \text{ k}\Omega$), low capacitance ($< 2 \text{ pF}$) scope probes with a wide bandwidth (1 GHz) scope. Improper probing will skew results.

9.2.2.5 Interconnecting Media

The physical communication channel between the LVDS driver and the LVDS receiver may be any balanced and paired metal conductors meeting the requirements of the LVDS standard, the key points of which are included here. This media may be twisted-pair, twinax cables, flat ribbon cables, or PCB traces. The nominal characteristic impedance of the interconnect media should be between 100Ω and 120Ω with a variation of no more than 10% (90Ω to 132Ω). Balanced cables (for example, twisted pair) are usually better than unbalanced cables (ribbon cable, simple coax.) for noise reduction and signal quality. Balanced cables tend to generate less EMI due to field canceling effects and also tend to pick up electromagnetic radiation a common-mode (not differential mode) noise which is rejected by the receiver. There should not introduce major impedance discontinuities in the system.

9.2.3 Application Curve

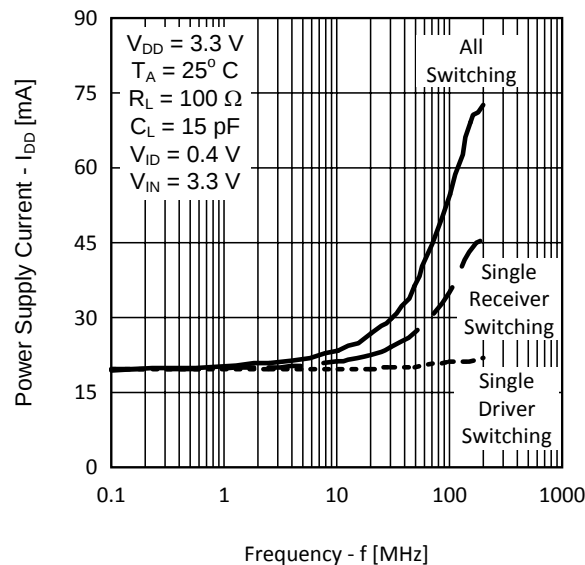


Figure 14. Power Supply Current vs Frequency

10 Power Supply Recommendations

The DS90LV049H LVDS transceiver is designed to operate from a single power supply with supply voltage in the range of 3.0 V to 3.6 V. In a typical point-to-point application, a driver and a receiver may be on separate boards, or even separate equipment. In these cases, separate supplies would be used at each location. The expected ground potential difference between the driver power supply and the driver power supply would be less than $|\pm 1 \text{ V}|$. Board level and local device level bypass capacitance should be used.

11 Layout

11.1 Layout Guidelines

11.1.1 Microstrip vs. Stripline Topologies

As per the [LVDS Application and Data Handbook](#) (SLLD009), printed-circuit boards usually offer designers two transmission line options: microstrip and stripline. Microstrips are traces on the outer layer of a PCB, as shown in [Figure 15](#).

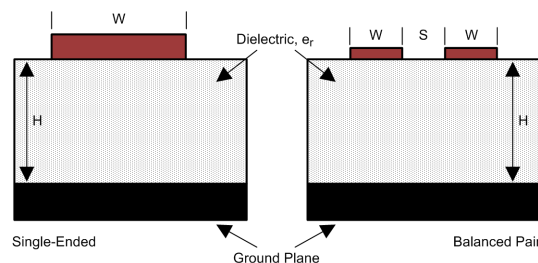


Figure 15. Microstrip Topology

Layout Guidelines (continued)

On the other hand, striplines are traces between two ground planes. Striplines are less prone to emissions and susceptibility problems because the reference planes effectively shield the embedded traces. However, from the standpoint of high-speed transmission, juxtaposing two planes creates additional capacitance. TI recommends routing LVDS signals on microstrip transmission lines when possible. The PCB traces allow designers to specify the necessary tolerances for Z_0 based on the overall noise budget and reflection allowances. Footnotes 1⁽²⁾, 2⁽³⁾, and 3⁽⁴⁾ provide formulas for Z_0 and t_{PD} for differential and single-ended traces. ⁽²⁾ ⁽³⁾ ⁽⁴⁾

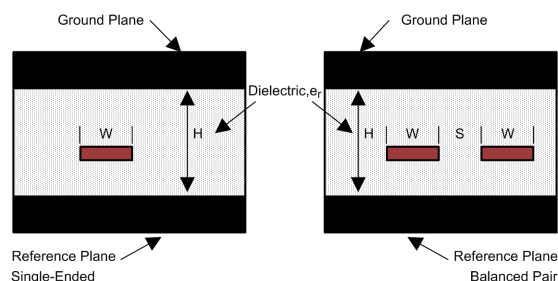


Figure 16. Stripline Topology

11.1.2 Dielectric Type and Board Construction

The speeds at which signals travel across the board dictates the choice of dielectric. FR-4, or equivalent, usually provides adequate performance for use with LVDS signals. If rise or fall times of LVCMOS/LVTTL signals are less than 500 ps, empirical results indicate that a material with a dielectric constant near 3.4, such as Rogers™ 4350 or Nelco N4000-13 may be desired. When the designer chooses the dielectric, there are several parameters pertaining to the board construction that can affect performance. The following set of guidelines were developed experimentally through several designs involving LVDS devices:

- Copper weight: 15 g or 1/2 oz start, plated to 30 g or 1 oz
- All exposed circuitry should be solder-plated (60/40) to 7.62 μm or 0.0003 in (minimum).
- Copper plating should be 25.4 μm or 0.001 in (minimum) in plated-through-holes.
- Solder mask over bare copper with solder hot-air leveling

11.1.3 Recommended Stack Layout

Following the choice of dielectrics and design specifications, the designer must decide how many levels to use in the stack. To reduce the LVCMOS/LVTTL to LVDS crosstalk, it is good practice to have at least two separate signal planes as shown in Figure 17.

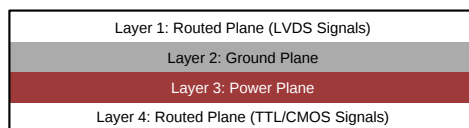


Figure 17. Four-Layer PCB Board

NOTE

The separation between layers 2 and 3 should be 127 μm (0.005 in). By keeping the power and ground planes tightly coupled, the increased capacitance acts as a bypass for transients.

- (2) Howard Johnson & Martin Graham. 1993. High Speed Digital Design – A Handbook of Black Magic. Prentice Hall PRT. ISBN number 013395724.
- (3) Mark I. Montrose. 1996. Printed Circuit Board Design Techniques for EMC Compliance. IEEE Press. ISBN number 0780311310.
- (4) Clyde F. Coombs, Jr. Ed, Printed Circuits Handbook, McGraw Hill, ISBN number 0070127549.

Layout Guidelines (continued)

One of the most common stack configurations is the six-layer board, as shown in [Figure 18](#).

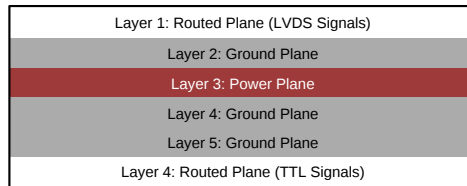


Figure 18. Six-Layer PCB Board

In this particular configuration, it is possible to isolate each signal layer from the power plane by at least one ground plane. The result is improved signal integrity, but fabrication is more expensive. Using the 6-layer board is preferable, because it offers the layout designer more flexibility in varying the distance between signal layers and referenced planes in addition to ensuring reference to a ground plane for signal layers 1 and 6.

11.1.4 Separation Between Traces

The separation between traces depends on several factors, but the amount of coupling that can be tolerated usually dictates the actual separation. Low-noise coupling requires close coupling between the differential pair of an LVDS link to benefit from the electromagnetic field cancellation. The traces should be 100-Ω differential and thus coupled in the manner that best fits this requirement. In addition, differential pairs should have the same electrical length to ensure that they are balanced, thus minimizing problems with skew and signal reflection.

In the case of two adjacent single-ended traces, one should use the 3-W rule, which stipulates that the distance between two traces must be greater than two times the width of a single trace, or three times its width measured from trace center to trace center. This increased separation effectively reduces the potential for crosstalk. The same rule should be applied to the separation between adjacent LVDS differential pairs, whether the traces are edge-coupled or broad-side-coupled.

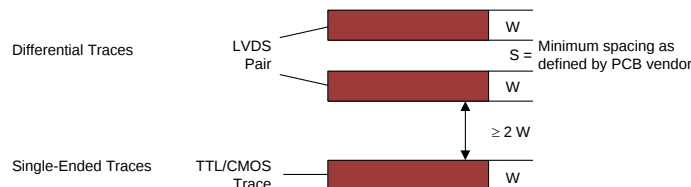


Figure 19. 3-W Rule for Single-Ended and Differential Traces (Top View)

Exercise caution when using autorouters, because they do not always account for all factors affecting crosstalk and signal reflection. For instance, it is best to avoid sharp 90° turns to prevent discontinuities in the signal path. Using successive 45° turns tends to minimize reflections.

11.1.5 Crosstalk and Ground Bounce Minimization

To reduce crosstalk, it is important to provide a return path to high-frequency currents that is as close to its originating trace as possible. A ground plane usually achieves this. Because the returning currents always choose the path of lowest inductance, they are most likely to return directly under the original trace, thus minimizing crosstalk. Lowering the area of the current loop lowers the potential for crosstalk. Traces kept as short as possible with an uninterrupted ground plane running beneath them emit the minimum amount of electromagnetic field strength. Discontinuities in the ground plane increase the return path inductance and should be avoided.

11.1.6 Decoupling

Each power or ground lead of a high-speed device should be connected to the PCB through a low inductance path. For best results, one or more vias are used to connect a power or ground pin to the nearby plane. TI recommends that the user place a via immediately adjacent to the pin to avoid adding trace inductance. Placing a power plane closer to the top of the board reduces the effective via length and its associated inductance.

Layout Guidelines (continued)

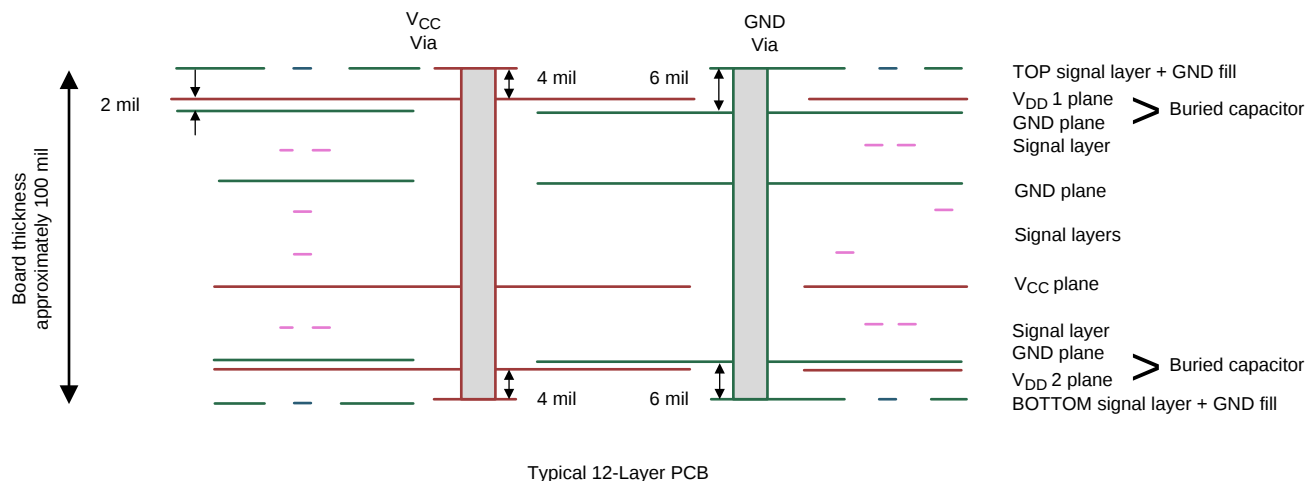


Figure 20. Low Inductance, High-Capacitance Power Connection

Bypass capacitors should be placed close to V_{DD} pins. They can be placed conveniently near the corners or underneath the package to minimize the loop area. This extends the useful frequency range of the added capacitance. Small-physical-size capacitors, such as 0402 or even 0201, or X7R surface-mount capacitors should be used to minimize body inductance of capacitors. Each bypass capacitor is connected to the power and ground plane through vias tangent to the pads of the capacitor as shown in Figure 21(a).

An X7R surface-mount capacitor of size 0402 has about 0.5 nH of body inductance. At frequencies above 30 MHz or so, X7R capacitors behave as low-impedance inductors. To extend the operating frequency range to a few hundred MHz, an array of different capacitor values like 100 pF, 1 nF, 0.03 μ F, and 0.1 μ F are commonly used in parallel. The most effective bypass capacitor can be built using sandwiched layers of power and ground at a separation of 2 to 3 mils. With a 2-mil FR4 dielectric, there is approximately 500 pF per square inch of PCB. Refer back to Figure 13 for some examples. Many high-speed devices provide a low-inductance GND connection on the backside of the package. This center dap must be connected to a ground plane through an array of vias. The via array reduces the effective inductance to ground and enhances the thermal performance of the small Surface Mount Technology (SMT) package. Placing vias around the perimeter of the dap connection ensures proper heat spreading and the lowest possible die temperature. Placing high-performance devices on opposing sides of the PCB using two GND planes (as shown in Figure 13) creates multiple paths for heat transfer. Often thermal PCB issues are the result of one device adding heat to another, resulting in a very high local temperature. Multiple paths for heat transfer minimize this possibility. In many cases the GND dap that is so important for heat dissipation makes the optimal decoupling layout impossible to achieve due to insufficient pad-to-dap spacing as shown in Figure 21(b). When this occurs, placing the decoupling capacitor on the backside of the board keeps the extra inductance to a minimum. It is important to place the V_{DD} via as close to the device pin as possible while still allowing for sufficient solder mask coverage. If the via is left open, solder may flow from the pad and into the via barrel. This will result in a poor solder connection.



Figure 21. Typical Decoupling Capacitor Layouts

Layout Guidelines (continued)

At least two or three times the width of an individual trace should separate single-ended traces and differential pairs to minimize the potential for crosstalk. Single-ended traces that run in parallel for less than the wavelength of the rise or fall times usually have negligible crosstalk. Increase the spacing between signal paths for long parallel runs to reduce crosstalk. Boards with limited real estate can benefit from the staggered trace layout, as shown in [Figure 22](#).

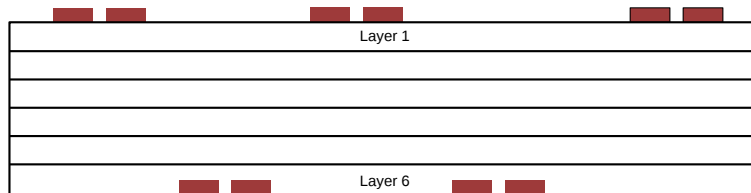


Figure 22. Staggered Trace Layout

This configuration lays out alternating signal traces on different layers. Thus, the horizontal separation between traces can be less than 2 or 3 times the width of individual traces. To ensure continuity in the ground signal path, TI recommends having an adjacent ground via for every signal via, as shown in [Figure 23](#). Note that vias create additional capacitance. For example, a typical via has a lumped capacitance effect of 1/2 pF to 1 pF in FR4.

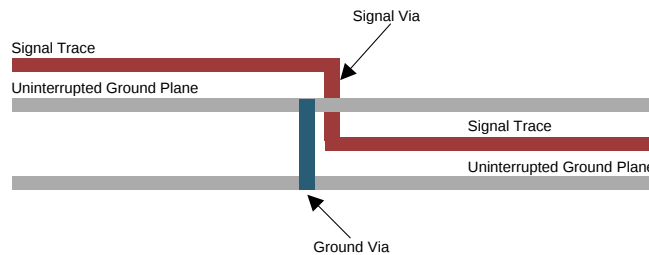


Figure 23. Ground Via Location (Side View)

Short and low-impedance connection of the device ground pins to the PCB ground plane reduces ground bounce. Holes and cutouts in the ground planes can adversely affect current return paths if they create discontinuities that increase returning current loop areas.

To minimize EMI problems, TI recommends avoiding discontinuities below a trace (for example, holes, slits, and so on) and keeping traces as short as possible. Zoning the board wisely by placing all similar functions in the same area, as opposed to mixing them together, helps reduce susceptibility issues.

11.2 Layout Example

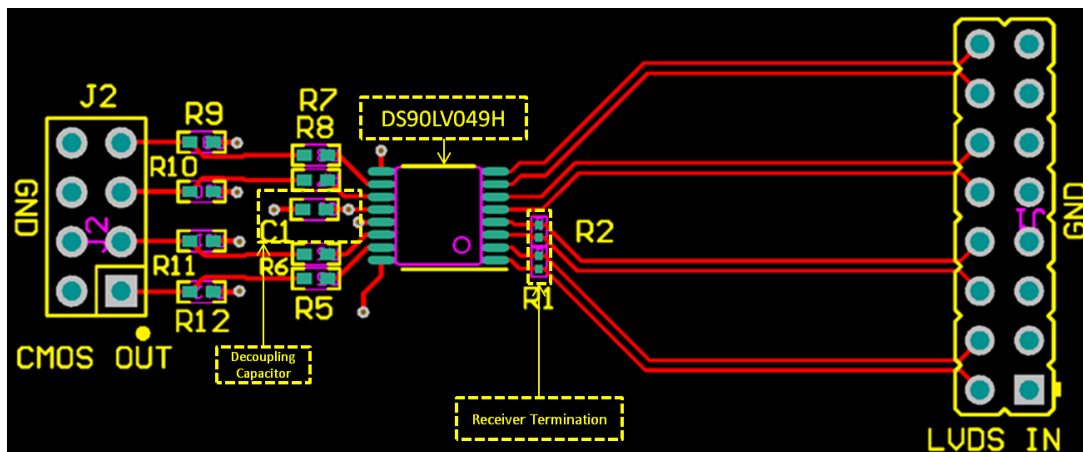


Figure 24. Example DS90LV049H Layout

12 器件和文档支持

12.1 相关文档

请参阅如下相关文档：

- [《LVDS 用户手册》 \(SNLA187\)](#)
- [《AN-808 长距离传输线路和数据信号质量》 \(SNLA028\)](#)
- [《AN-977 LVDS 信号质量：使用眼图测量抖动测试报告 #1》 \(SNLA166\)](#)
- [《AN-971 LVDS 技术概览》 \(SNLA165\)](#)
- [《AN-916 电缆选择实用指南》 \(SNLA219\)](#)
- [《AN-805 差分线路驱动器功耗计算》 \(SNOA233\)](#)
- [《AN-903 差分终端技巧对比》 \(SNLA034\)](#)
- [《LVDS 接口的 AN-1194 失效防护偏置》 \(SNLA051\)](#)

12.2 接收文档更新通知

要接收文档更新通知，请导航至 [TI.com.cn](#) 上的器件产品文件夹。单击右上角的 [通知我](#) 进行注册，即可每周接收产品信息更改摘要。有关更改的详细信息，请查看任何已修订文档中包含的修订历史记录。

12.3 社区资源

下列链接提供到 TI 社区资源的连接。链接的内容由各个分销商“按照原样”提供。这些内容并不构成 TI 技术规范，并且不一定反映 TI 的观点；请参阅 TI 的 [《使用条款》](#)。

TI E2E™ 在线社区 [TI 的工程师对工程师 \(E2E\) 社区](#)。此社区的创建目的在于促进工程师之间的协作。在 [e2e.ti.com](#) 中，您可以咨询问题、分享知识、拓展思路并与同行工程师一道帮助解决问题。

设计支持 [TI 参考设计支持](#) 可帮助您快速查找有帮助的 E2E 论坛、设计支持工具以及技术支持的联系信息。

12.4 商标

E2E is a trademark of Texas Instruments.

Rogers is a trademark of Rogers Corporation.

All other trademarks are the property of their respective owners.

12.5 静电放电警告



ESD 可能会损坏该集成电路。德州仪器 (TI) 建议通过适当的预防措施处理所有集成电路。如果不遵守正确的处理措施和安装程序，可能会损坏集成电路。

ESD 的损坏小至导致微小的性能降级，大至整个器件故障。精密的集成电路可能更容易受到损坏，这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

12.6 术语表

[SLYZ022](#) — [TI 术语表](#)。

这份术语表列出并解释术语、缩写和定义。

13 机械、封装和可订购信息

以下页面包含机械、封装和可订购信息。这些信息是指定器件的最新可用数据。数据如有变更，恕不另行通知，且不会对此文档进行修订。如需获取此数据表的浏览器版本，请查阅左侧的导航栏。

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
DS90LV049HMT/NOPB	Active	Production	TSSOP (PW) 16	92 TUBE	Yes	SN	Level-1-260C-UNLIM	-40 to 125	90LV049 HMT
DS90LV049HMT/NOPB.A	Active	Production	TSSOP (PW) 16	92 TUBE	Yes	SN	Level-1-260C-UNLIM	-40 to 125	90LV049 HMT
DS90LV049HMTX/NOPB	Active	Production	TSSOP (PW) 16	2500 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	90LV049 HMT
DS90LV049HMTX/NOPB.A	Active	Production	TSSOP (PW) 16	2500 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	90LV049 HMT
DS90LV049HMTX/NOPB.B	Active	Production	TSSOP (PW) 16	2500 LARGE T&R	-	Call TI	Call TI	-40 to 125	

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "-" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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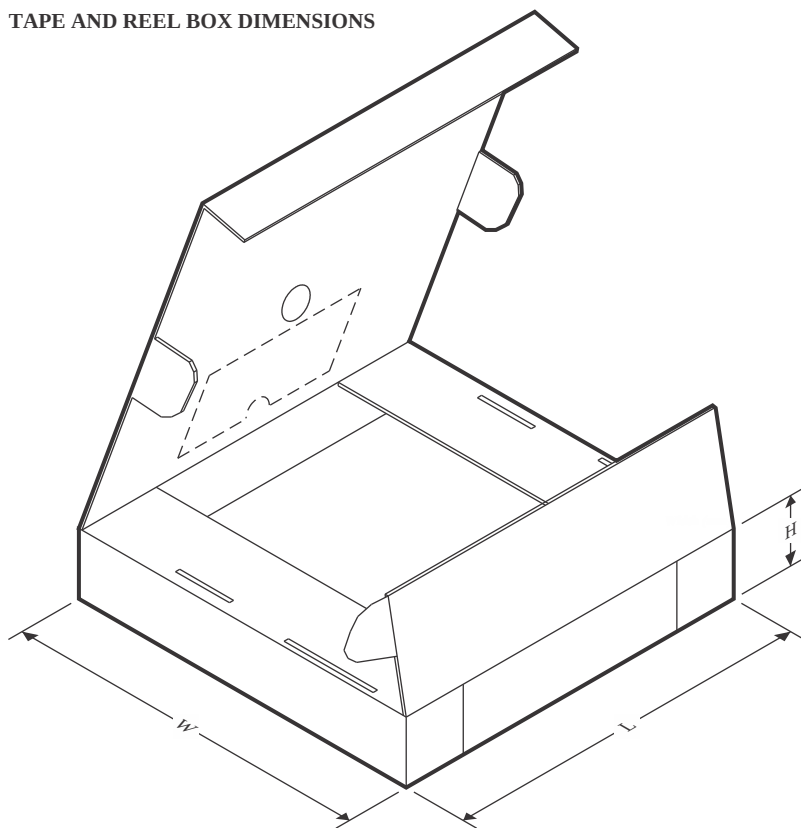
TAPE AND REEL INFORMATION



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
DS90LV049HMTX/NOPB	TSSOP	PW	16	2500	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

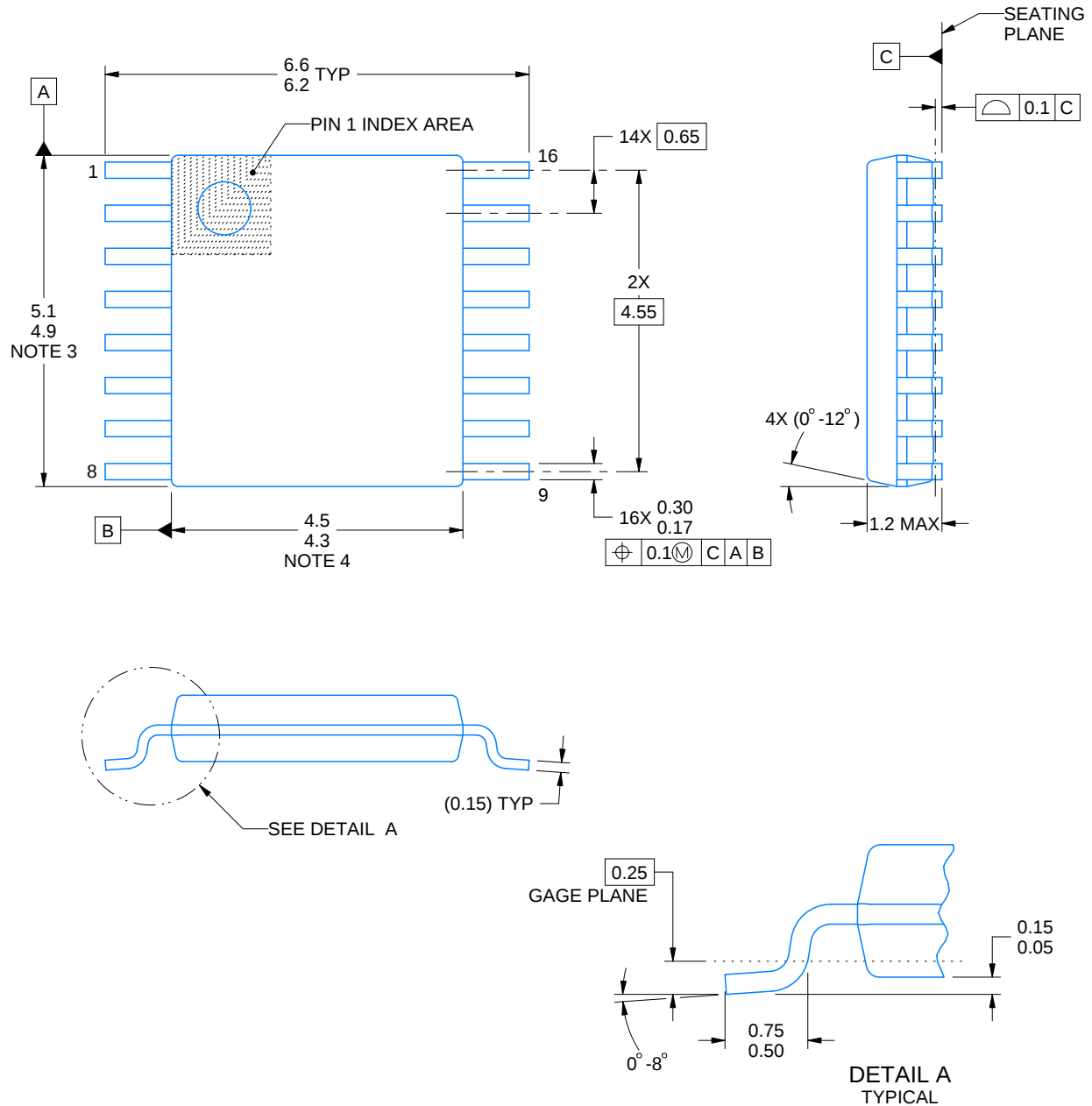
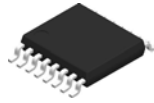
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
DS90LV049HMTX/NOPB	TSSOP	PW	16	2500	367.0	367.0	35.0

TUBE



*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (μm)	B (mm)
DS90LV049HMT/NOPB	PW	TSSOP	16	92	495	8	2514.6	4.06
DS90LV049HMT/NOPB.A	PW	TSSOP	16	92	495	8	2514.6	4.06



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NOTES:

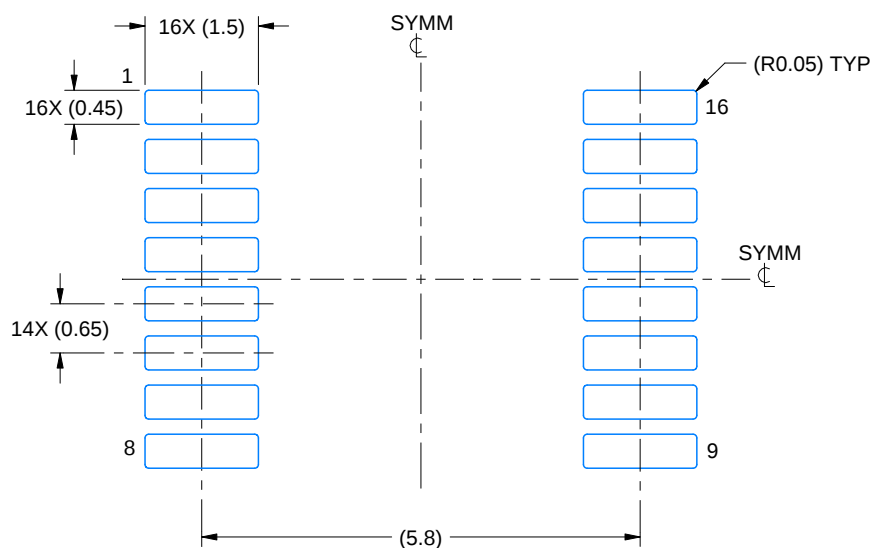
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-153.

EXAMPLE BOARD LAYOUT

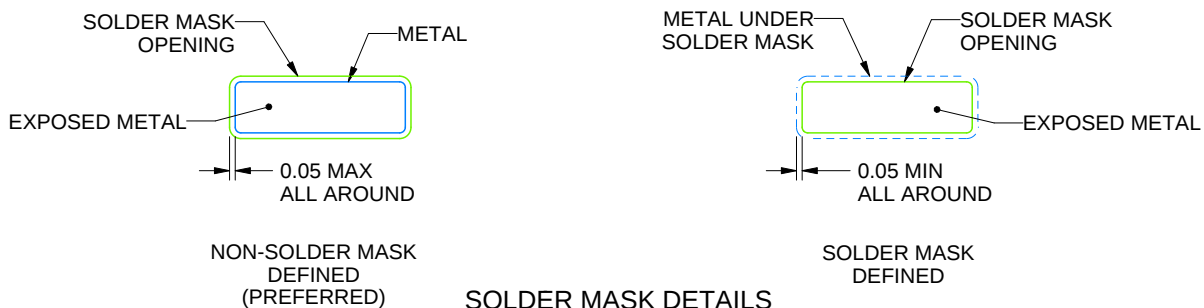
PW0016A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 10X



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NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

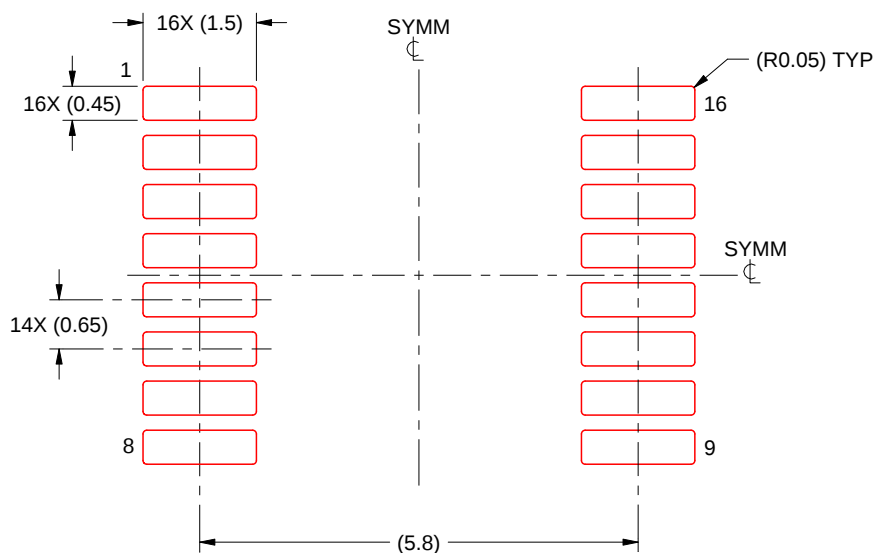
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

PW0016A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE: 10X

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NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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最后更新日期：2025 年 10 月